



## • General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

## • Features

- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

## • Application

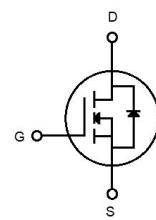
- BLDC Motor driver
- DC-DC
- Load Switch

## • Ordering Information:

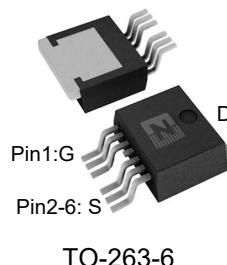
|                           |              |
|---------------------------|--------------|
| Part NO.                  | ZMS005N04HB6 |
| Marking                   | ZMS005N04H   |
| Packing Information       | REEL TAPE    |
| Basic ordering unit (pcs) | 800          |

## • Absolute Maximum Ratings ( $T_c=25^\circ\text{C}$ )

| Parameter                        | Symbol    | Conditions  | Value       | Unit             |
|----------------------------------|-----------|---|-------------|------------------|
| Drain-Source Voltage             | $V_{DS}$  |   | 40          | V                |
| Gate-Source Voltage <sup>①</sup> | $V_{GS}$  |   | $\pm 20$    | V                |
| Continuous Drain Current         | $I_D$     | $T_c=25^\circ\text{C}$  | 300         | A                |
|                                  | $I_D$     | $T_c=75^\circ\text{C}$  | 300         | A                |
|                                  | $I_D$     | $T_c=100^\circ\text{C}$   | 275         | A                |
| Pulsed Drain Current             | $I_{DM}$  | Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ | 1200        | A                |
| Total Power Dissipation          | $P_D$     | $T_c=25^\circ\text{C}$  | 278         | W                |
| Total Power Dissipation          | $P_D$     | $T_A=25^\circ\text{C}$  | 3.5         | W                |
| Operating Junction Temperature   | $T_J$     |   | -55 to +150 | $^\circ\text{C}$ |
| Storage Temperature              | $T_{STG}$ |   | -55 to +150 | $^\circ\text{C}$ |
| Single Pulse Avalanche Energy    | $E_{AS}$  | $L=0.1\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,       | 756         | mJ               |
|                                  |           | $L=0.5\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,       | 1210        | mJ               |
| ESD Level (HBM)                  |           |   | CLASS 2     |                  |



$V_{DS}=40\text{V}$   
 $R_{DS(ON)}=0.55\text{m}\Omega$   
 $I_D=300\text{A}$





## •Thermal resistance

| Parameter                            | Symbol           | Min. | Typ. | Max. | Unit |
|--------------------------------------|------------------|------|------|------|------|
| Thermal resistance, junction - case  | $R_{thJC}$       |      | -    | 0.45 | °C/W |
| Thermal resistance, junction-ambient | $R_{thJA}^{(2)}$ |      | -    | 36   | °C/W |
| Soldering temperature                | $T_{sold}$       |      | -    | 260  | °C   |

## •Electronic Characteristics

| Parameter                         | Symbol       | Condition                         | Min. | Typ. | Max. | Unit      |
|-----------------------------------|--------------|-----------------------------------|------|------|------|-----------|
| Drain-Source Breakdown Voltage    | $BV_{DSS}$   | $V_{GS} = 0V, I_D = 250\mu A$     | 40   |      |      | V         |
| Gate Threshold Voltage            | $V_{GS(TH)}$ | $V_{GS} = V_{DS}, I_D = 250\mu A$ | 2    | 2.7  | 4    | V         |
| Drain-Source Leakage Current      | $I_{DSS}$    | $V_{GS} = 0V, V_{DS} = 40V$       |      |      | 1.0  | $\mu A$   |
| Gate- Source Leakage Current      | $I_{GSS}$    | $V_{GS} = \pm 20V, V_{DS} = 0V$   |      |      | 100  | nA        |
| Static Drain-source On Resistance | $R_{DS(ON)}$ | $V_{GS} = 10V, I_D = 40A$         |      | 0.55 | 0.7  | $m\Omega$ |
| Forward Transconductance          | $g_{FS}$     | $V_{GS} = 5V, I_{SD} = 10A$       |      | 30   |      | s         |
| Diode Forward Voltage             | $V_{FSD}$    | $V_{GS} = 0V, I_{SD} = 40A$       |      |      | 1.3  | V         |

## •Dynamic characteristics

| Parameter                    | Symbol       | Condition  | Min. | Typ.  | Max. | Unit     |
|------------------------------|--------------|--|------|-------|------|----------|
| Input capacitance            | $C_{iss}$    | $f = 1MHz, V_{DS} = 25V$                                 | -    | 10620 | -    | pF       |
| Output capacitance           | $C_{oss}$    |  | -    | 2810  | -    |          |
| Reverse transfer capacitance | $C_{rss}$    |  | -    | 115   | -    |          |
| Gate Resistance              | $R_g$        | $f = 1MHz$   | -    | 1.6   |      | $\Omega$ |
| Total gate charge            | $Q_g$        | $V_{DD} = 15V, I_D = 20A, V_{GS} = 10V$                  | -    | 155   | -    | nC       |
| Gate - Source charge         | $Q_{gs}$     |  | -    | 35    | -    |          |
| Gate - Drain charge          | $Q_{gd}$     |  | -    | 32    | -    |          |
| Turn-ON Delay time           | $t_{D(on)}$  | $V_{GS} = 10V, V_{DS} = 15V, R_G = 3.3\Omega, I_D = 20A$ | -    | 65    | -    | ns       |
| Turn-ON Rise time            | $t_r$        |  | -    | 31    | -    | ns       |
| Turn-Off Delay time          | $t_{D(off)}$ |  | -    | 85    | -    | ns       |
| Turn-Off Fall time           | $t_f$        |  | -    | 78    | -    | ns       |
| Reverse Recovery Time        | $t_{RR}$     | $V_{DD} = 20V, dI_S/dt = 100A/us, I_S = 50A$             | -    | 97    | -    | ns       |
| Reverse Recovery Charge      | $Q_{RR}$     |  | -    | 135   | -    | nC       |



Fig.1 Gate-Charge Characteristics

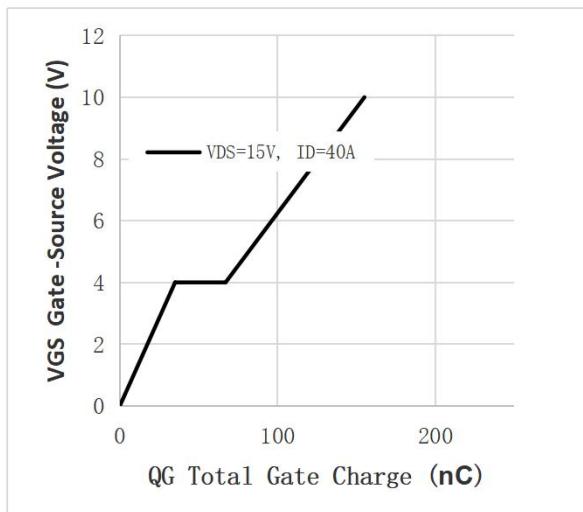


Fig.2 Capacitance Characteristics

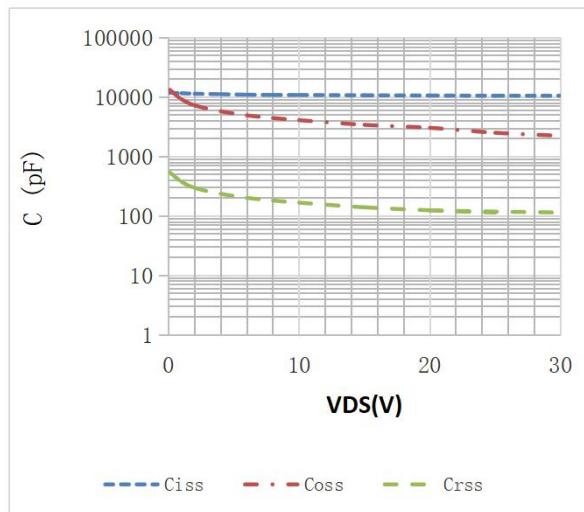


Fig.3 Power Dissipation

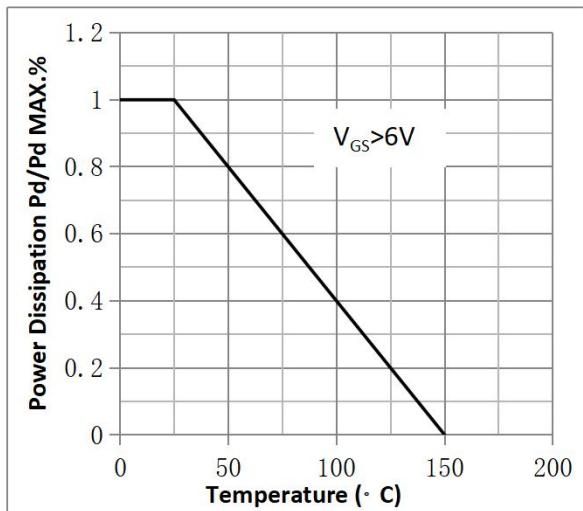


Fig.4 Typical output Characteristics

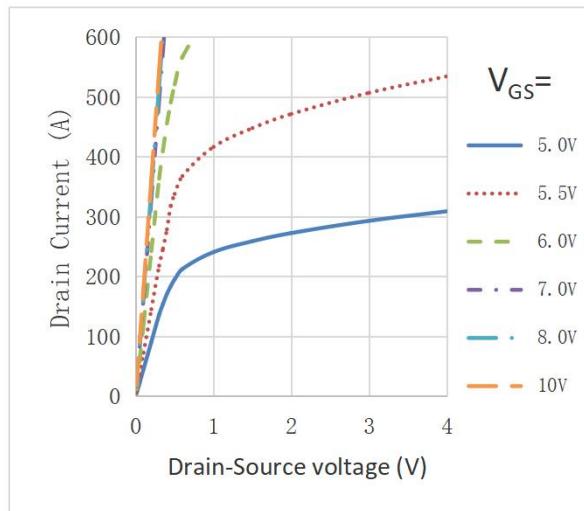


Fig.5 Threshold Voltage V.S Junction Temperature

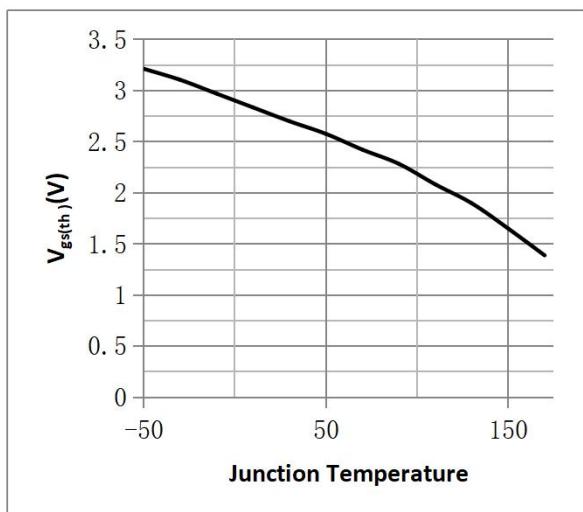


Fig.6 Resistance V.S Drain Current

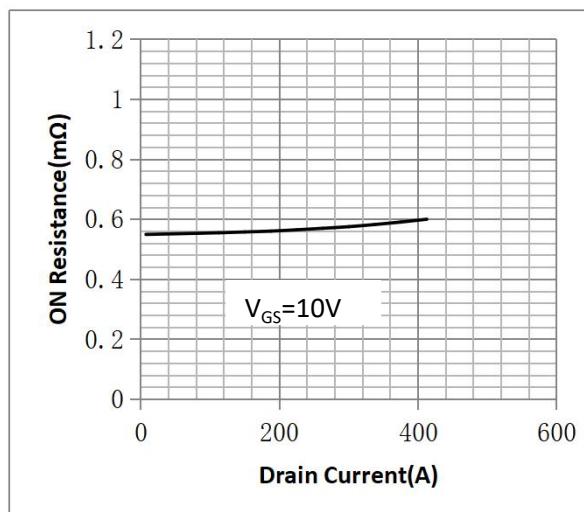




Fig.7 On-Resistance VS Gate Source Voltage

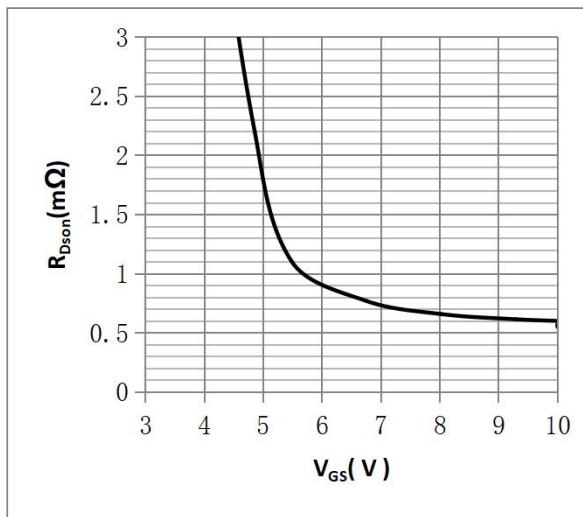


Figure 9. Diode Forward Voltage vs. Current

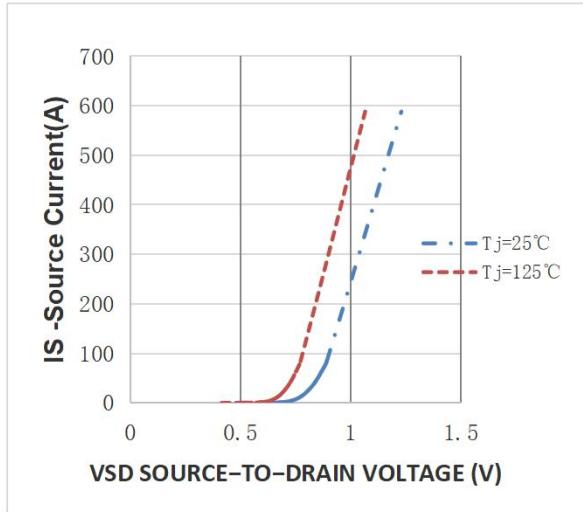


Fig.11 Safe Operating Area

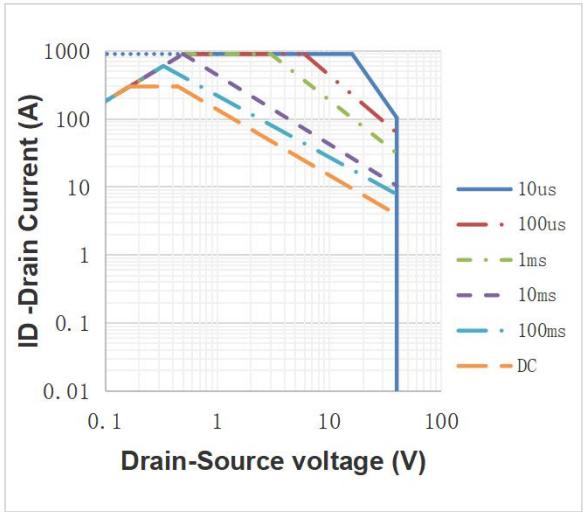


Fig.8 On-Resistance V.S Junction Temperature

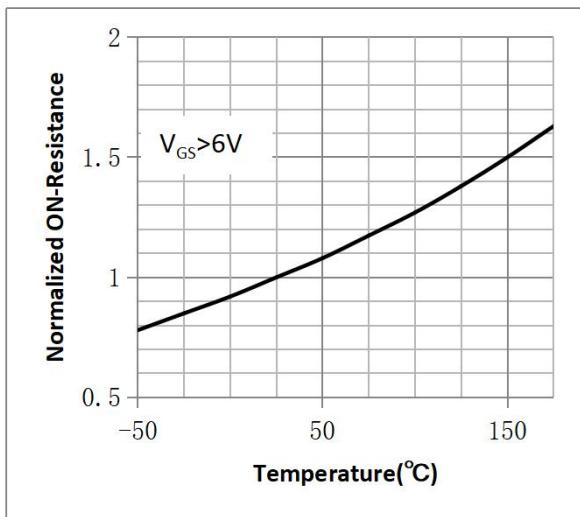
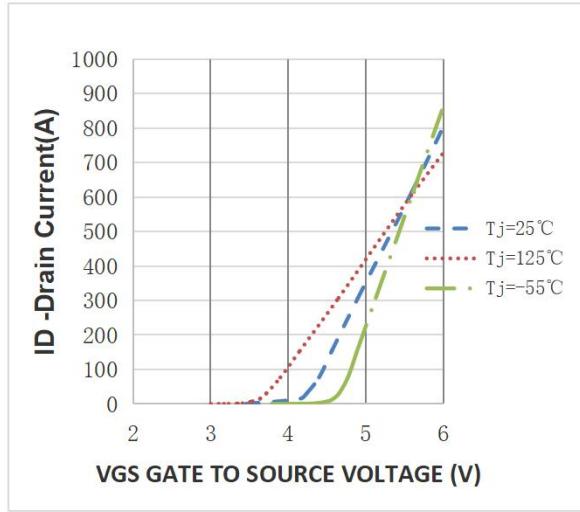
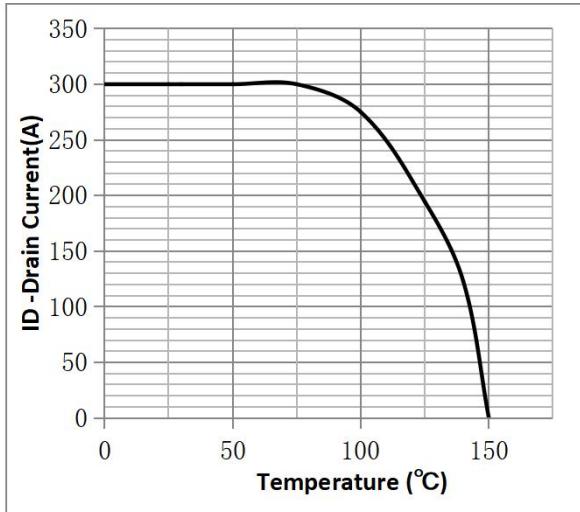
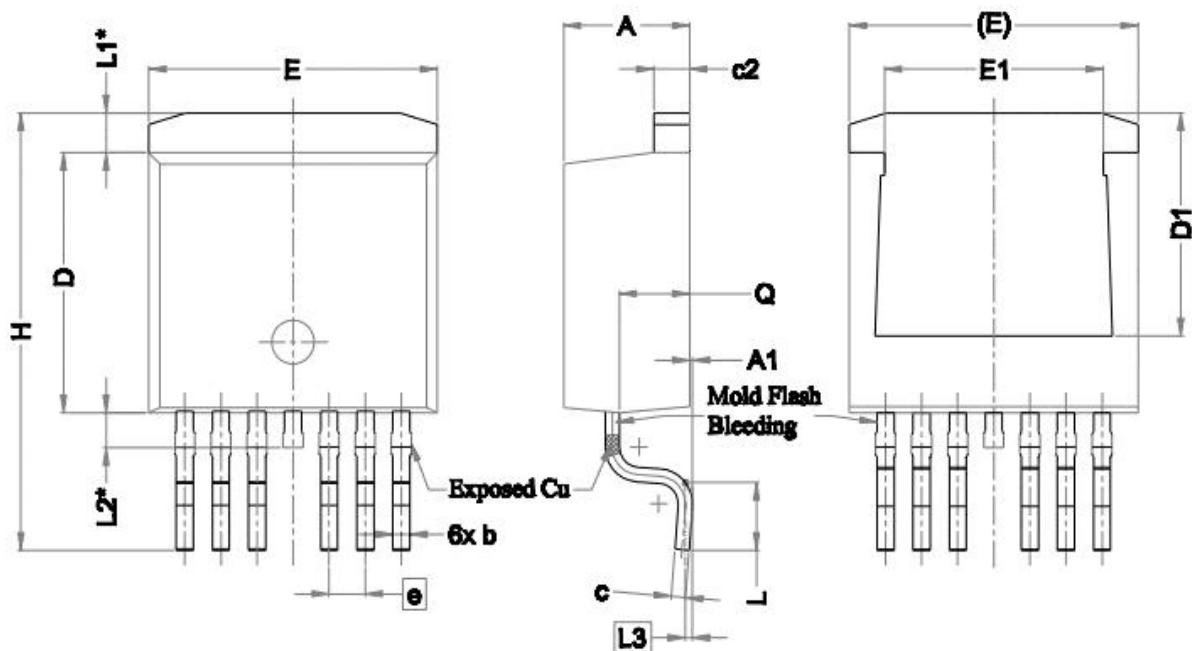


Figure 10. Transfer Characteristics

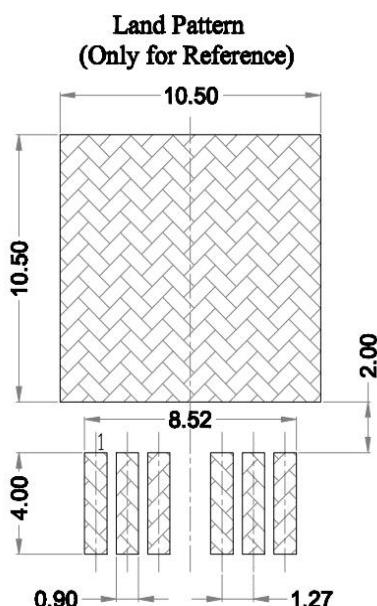
Fig.12 ID vs. Junction Temperature<sup>③</sup>



## •TO-263-6 Package Outline



| SYMBOL | DIMENSIONS |       |       |
|--------|------------|-------|-------|
|        | MIN.       | NOM.  | MAX.  |
| A      | 4.24       | 4.44  | 4.64  |
| A1     | 0.00       | 0.10  | 0.25  |
| b      | 0.50       | 0.60  | 0.70  |
| c      | 0.40       | 0.50  | 0.60  |
| c2     | 1.15       | 1.27  | 1.40  |
| D      | 8.82       | 8.92  | 9.02  |
| D1     | 6.86       | 7.65  | —     |
| E      | 9.96       | 10.16 | 10.36 |
| E1     | 6.89       | 7.77  | 7.89  |
| e      | 1.27 BSC   |       |       |
| H      | 14.61      | 15.00 | 15.88 |
| L      | 1.78       | 2.32  | 2.79  |
| L1     | 1.36 REF.  |       |       |
| L2     | 1.20 REF.  |       |       |
| L3     | 0.25 BSC   |       |       |
| Q      | 2.30       | 2.48  | 2.70  |



**Note:**

- ① Pulse : VGS=+20V/-20V, Duty cycle=50%, Tj=175°C, t=1000 hours; For DC , the following test conditions can be passed: VGS=+20V/-10V, Tj=175°C, t=1000 hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature. VGS=10V.

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## Revision History

| Version | Date      | Change                                      |
|---------|-----------|---|
| A       | 2023.1.15 | new   |
| B       | 2023.5.10 | 1.Add Reach, HF figure<br>2.ID curve modify |
|         |           |   |
|         |           |   |
|         |           |   |
|         |           |   |
|         |           |   |